COMPLIANT

HALOGEN

FREE





N-Channel 80 V (D-S) MOSFET



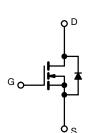
PRODUCT SUMMARY				
V _{DS} (V)	80			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.0102			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 7.5 \text{ V}$	0.0125			
Q _g typ. (nC)	16			
I _D (A)	45.1 ^{a, g}			
Configuration	Single			

FEATURES

- TrenchFET® Gen IV power MOSFET
- Very low R_{DS} x Q_g figure-of-merit (FOM)
- Tuned for the lowest R_{DS} x Q_{oss} FOM
- 100 % R_a and UIS tested
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- · Synchronous rectification
- · Primary side switch
- DC/DC converter
- · Motor drive switch
- · Battery and load switch
- Industrial



N-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK 1212-8
Lead (Pb)-free and halogen-free	SiS126DN-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V _{DS}	80	V
Gate-source voltage		V _{GS}	± 20	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		45.1	
	T _C = 70 °C		36.1	
	T _A = 25 °C	I _D	12 ^{b, c}	
	T _A = 70 °C		9.7 ^{b, c}	•
Pulsed drain current (t = 100 µs)		I _{DM}	100	A
Continuous source-drain diode current	T _C = 25 °C		47.2	
	T _A = 25 °C	I _S	3.3 b, c	
Single pulse avalanche current	. 0.111	I _{AS}	20	
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	20	mJ
Maximum power dissipation	T _C = 25 °C		52	
	T _C = 70 °C	5	33.3	14/
	T _A = 25 °C	P _D	3.7 ^{b, c}	W
	T _A = 70 °C		2.4 b, c	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	20
Soldering recommendations (peak temperature) c		9	260	°C

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	24	33	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	1.9	2.4	7 C/W	

Notes

- b. Surface mounted on 1" x 1" FR4 board

S19-0093-Rev. A, 04-Feb-2019

- t=10~s See solder profile (www.vishav.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection Rework conditions: manual soldering with a soldering iron is not recommended for leadless components Maximum under steady state conditions is 81 °C/W $T_C = 25~°C$

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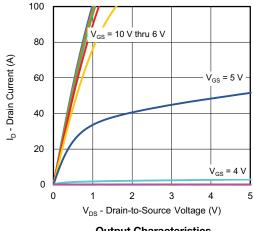
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80	-	_	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	63	-		
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	6.6 -		-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	3.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
7	,	V _{DS} = 80 V, V _{GS} = 0 V	-	-	1	_	
Zero gate voltage drain current	IDSS	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	40	-	-	Α	
Duning and the second of the s	_	V _{GS} = 10 V, I _D = 10 A	-	0.0085	0.0102	Ω	
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	0.0097	0.0125		
Forward transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_{D} = 10 \text{ A}$	-	39	-	S	
Dynamic ^b					•		
Input capacitance	C _{iss}	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz	-	1402	-	pF	
Output capacitance	C _{oss}		-	176	-		
Reverse transfer capacitance	C _{rss}		-	11.2	-		
Tatal asta shaws	0	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ $V_{DS} = 40 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	21.1	32	nC	
Total gate charge	Qg		-	16	24		
Gate-source charge	Q _{gs}		-	6.5	-		
Gate-drain charge	Q _{gd}		-	3.4	-		
Output charge	Q _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$	-	23.5	-		
Gate resistance	R_g	f = 1 MHz	0.2	0.76	1.4	Ω	
Turn-on delay time	t _{d(on)}		-	13	26		
Rise time	t _r	$\begin{split} V_{DD} = 40 \text{ V}, \text{ R}_L = 4 \Omega, \text{ I}_D &\cong 10 \text{ A}, \\ V_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega \end{split}$	-	6	12		
Turn-off delay time	t _{d(off)}		-	16	32		
Fall time	t _f		-	6	12		
Turn-on delay time	t _{d(on)}		-	14	28	ns	
Rise time	t _r	$\begin{split} V_{DD} = 40 \text{ V}, \text{ R}_L = 4 \Omega, \text{ I}_D &\cong 10 \text{ A}, \\ V_{GEN} = 7.5 \text{ V}, \text{ R}_g = 1 \Omega \end{split}$	-	6	12		
Turn-off delay time	t _{d(off)}		-	15	30		
Fall time	t _f		-	6	12		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	47.2	^	
Pulse diode forward current	I _{SM}		-	-	10	A	
Body diode voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.78	1.1	V	
Body diode reverse recovery time	t _{rr}		-	36	72	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	43	86	nC	
Reverse recovery fall time	ta	$T_J = 25 ^{\circ}C$	-	24	-		
Reverse recovery rise time	t _b		-	12	-	ns	

Notes

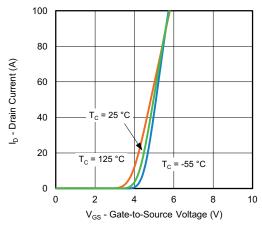
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

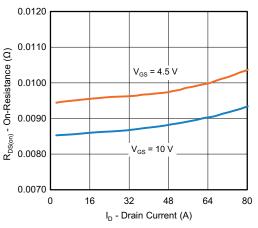




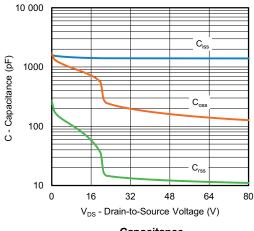




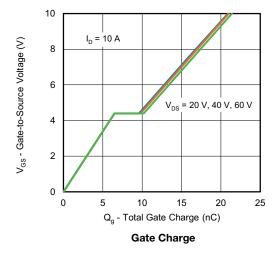
Transfer Characteristics

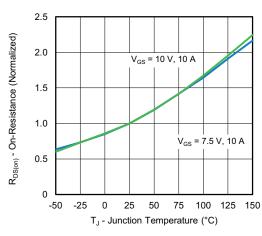


On-Resistance vs. Drain Current and Gate Voltage



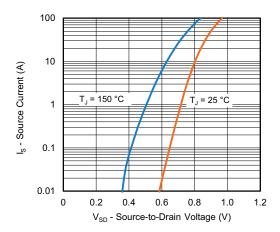
Capacitance



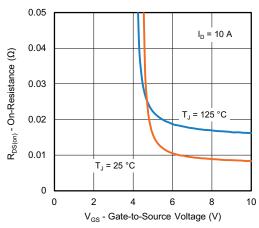


On-Resistance vs. Junction Temperature

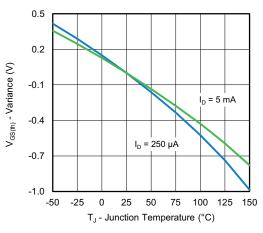




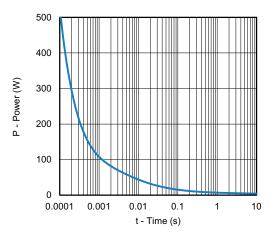
Source-Drain Diode Forward Voltage



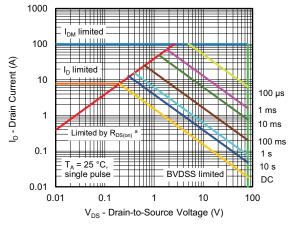
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

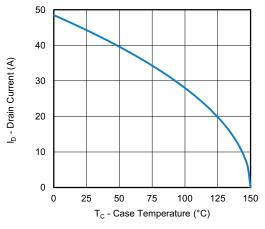


Safe Operating Area, Junction-to-Ambient

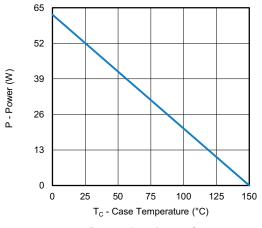
Note

a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

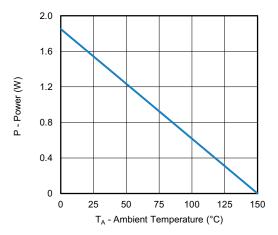




Current Derating a



Power, Junction-to-Case

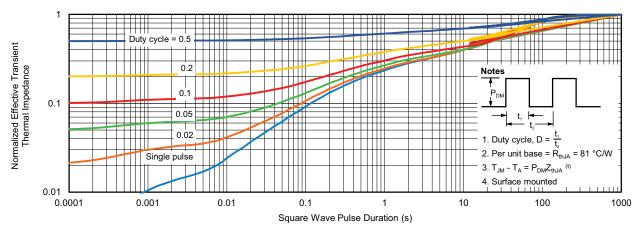


Power, Junction-to-Ambient

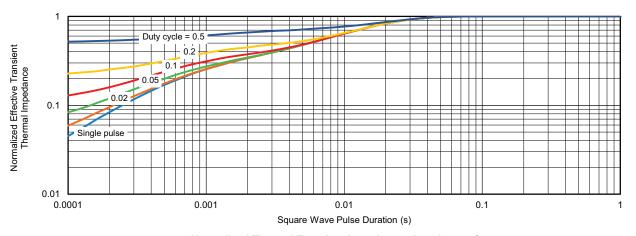
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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